

Elements of electrical and optical connection — Test methods —

Part 323: Thermal shock

The European Standard EN 2591-323:1998 has the status of a
British Standard

ICS 49.060

National foreword

This British Standard is the English language version of EN 2591-323:1998. The UK participation in its preparation was entrusted by Technical Committee ACE/6, Aerospace avionic, electrical and fibre optic technology, to Subcommittee ACE/6/3, Aerospace — Connectors, which has the responsibility to:

- aid enquirers to understand the text;
- present to the responsible international/European committee any enquiries on the interpretation, or proposals for change, and keep the UK interests informed;
- monitor related international and European developments and promulgate them in the UK.

A list of organizations represented on this subcommittee can be obtained on request to its secretary.

Cross-references

The British Standards which implement international or European publications referred to in this document may be found in the BSI Standards Catalogue under the section entitled “International Standards Correspondence Index”, or by using the “Find” facility of the BSI Standards Electronic Catalogue.

A British Standard does not purport to include all the necessary provisions of a contract. Users of British Standards are responsible for their correct application.

Compliance with a British Standard does not of itself confer immunity from legal obligations.

Summary of pages

This document comprises a front cover, an inside front cover, pages i and ii, the EN title page, pages 2 to 4 and a back cover. This standard has been updated (see copyright date) and may have had amendments incorporated. This will be indicated in the amendment table on the inside front cover.

This British Standard, having been prepared under the direction of the Engineering Sector Board, was published under the authority of the Standards Board and comes into effect on 15 August 1998

© BSI 05-1999

ISBN 0 580 30308 X

Amendments issued since publication

Amd. No.	Date	Comments